

Model : SCW08B-12 8W
+12V / 667mA

OUTPUT FUNCTION TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	OUTPUT VOLTAGE ACCURACY	-2%~+2%	I/P: 24VDC O/P:50% LOAD Ta:25°C	0.27%	P
2	RIPPLE & NOISE	60mVp-p	I/P:24VDC O/P:FULL LOAD Ta:25°C	24.8mVp-p	P
3	LINE REGULATION	-0.5%~+0.5%	I/P:18VDC ~36VDC O/P:FULL LOAD Ta:25°C	-0%~+0.01%	P
4	LOAD REGULATION	-0.5%~+0.5%	I/P:24VDC O/P: MIN ~FULL LOAD Ta:25°C	-0.03%~+0.03%	P

INPUT FUNCTION TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	INPUT VOLTAGE RANGE	18VDC~36VDC	I/P:TESTING O/P:FULL LOAD Ta:25°C	15.5V~36Vdc	P
2	EFFICIENCY	82% (Typ)	I/P:24VDC O/P:FULL LOAD Ta:25°C	86.3%	P
3	INPUT CURRENT	426mA FULL LOAD (Max.) 25mA NO LOAD (Typ.)	I/P:24VDC O/P:TEST Ta:25°C	389mA / FULL LOAD 15mA / NO LOAD	P

PROTECTION FUNCTION TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	OVER LOAD PROTECTION	110%~180%(Typ)	I/P:24VDC O/P:TESTING Ta:25°C	179% HICCUP MODE AUTO-RECOVER	P
2	SHORT PROTECTION	SHORT EVERY OUTPUT 1 HOUR NO DAMAGE	I/P:36VDC O/P:FULL LOAD Ta:25°C	NO DAMAGE HICCUP MODE AUTO-RECOVER	P

ENVIRONMENT TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT						
1	TEMPERATURE RISE TEST	1. ROOM AMBIENT BURN-IN : 3HRS I/P:24VDC O/P: FULL LOAD Ta= 24.5°C			P						
		<table border="1"> <tr> <td>Position</td> <td>P/N</td> <td>1</td> </tr> <tr> <td>CASE</td> <td>CENTER</td> <td>44.2°C</td> </tr> </table>		Position		P/N	1	CASE	CENTER	44.2°C	
Position	P/N	1									
CASE	CENTER	44.2°C									
2	LOW TEMPERATURE TURN ON TEST	TURN ON AFTER 3 HOURS	I/P:24VDC O/P: 100% LOAD Ta= -40°C	TEST : OK	P						

SAFETY TEST

NO	TEST ITEM	SPECICATION	TEST CONDITION	RESULT	VERDICT
1	WITHSTAND VOLTAGE	I/P-O/P:1000 VDC/min	I/P-O/P:1000 VDC/min Ta:25°C	I/P-O/P: 0.02mA NO DAMAGE	P
2	ISOLATION RESISTANCE	I/P-O/P:500VDC>100MΩ	I/P-O/P:500 VDC Ta:25°C	I/P-O/P>100MΩ NO DAMAGE	P

DATE	SAMPLE	TEST RESULT	TESTER	APPROVAL
2008.1.5	STOCK	PASS	PETER	T.K.CHENG